Search No	otes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/614,965	BOEHM ET AL.	
Examiner	Art Unit	
Alan S. Chen	2182	

SEARCHED				
Class	Subclass	Date	Examiner	
710	2	4/25/2005	ASC	
	9		1	
	10			
	11			
	12			
	13		·	
	14			
	62			
V	72	J	1	

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
		·			
		600			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
(EAST) USPAT; USPGPUB; EPO; JPO; IBM_TDB; DERWENT	4/25/2005	ASC	
updated IEEE Xplore see search litstory	8/29/05	ASC	
SEE JEWICH MAR LOND	7 ( ( ( ( ( ( ( ( ( ( ( ( ( ( ( ( ( ( (	1	
•			